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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)				Application Number	10/672,751
				Filing Date	September 26, 2003
				First Named Inventor	Paul VAN RIEL et al.
				Group Art Unit	2857
				Examiner Name	Anthony Gutierrez
Sheet	2	of	2	Attorney Docket Number	702-031290

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS					
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, cite and/or country where published.	T ²		
AG	AI	SIMMONS et al., "Waveform-based AVO inversion and AVO prediction-error," <i>Geophysics</i> 61(6) (November-December 1996) pp:1575-1588			
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AG	AM	SMITH et al., "Weighted stacking for rock property estimation and detection of gas," <i>Geophysical Prospecting</i> 35 (1987) pp: 993-1014			
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AG	AV	GILL et al., "Constrained nonlinear programming," G.L. Nemhauser et al. Eds., <i>Handbooks in OR & MS</i> 1 (1989) pp: 171-210, Elsevier Science Pub. B.V. (North-Holland)			

Examiner Signature	<i>Anthony Gutierrez</i>	Date Considered	5/24/04
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